FM-AFM on ice-brine interface at sub-zero temperature

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We have successfully examined the operation of atomic force microscopy (AFM) at sub-zero temperatures for the purpose of characterizing ice–liquid interfaces. Topographic imaging in amplitude-modulation mode and force curve measurements in contact mode were conducted on ice films under antifreeze organic solvents, using a Bruker microscope (Dimension XR Icon) [1]. A Shimadzu microscope (SPM-8100FM) equipped with frequency-modulation force detection capability was maintained at low temperatures in an acoustic enclosure (Fig. 1). Topographic imaging and force curve measurements were accomplished on graphite in 1-octanol liquid cooled to as low as – 15 °C [2]. In the present study, the operation of FM-AFM is examined on ice under aqueous solutions of NaCl. Figure 2 illustrates a two-dimensional map of the frequency shift of cantilever oscillation (Δf), where the cantilever scanned vertically from the bulk solution to the ice substrate. At the ice–solution interface, a layered modulation of Δf was identified, suggesting an uneven density distribution within the solution.

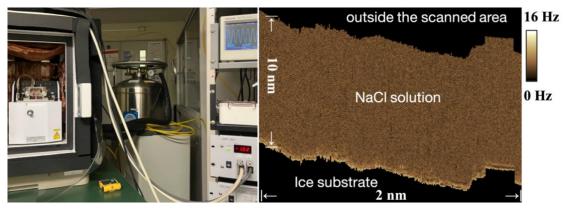


Figure 1. (left) The SPM-8100FM microscope installed in the enclosure for sub-zero temperature operation.

Figure 2. 2D (X-Z) frequency-shift map over ice under an aqueous solution of NaCl cooled at -2 °C. Cantilever oscillation amplitude: 0.79 nm. A large (or small) positive Δf is depicted using a bright (or dark) color.

References

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